

Description

The AP10G03S uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

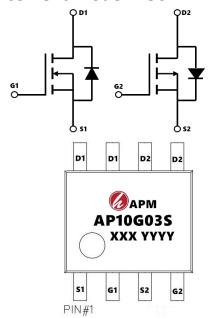
General Features

 $V_{DS} = 30V I_{D} = 12 A$

 $R_{DS(ON)}$ < 12m Ω @ V_{GS} =10V

 $V_{DS} = -30V I_{D} = -9.8 A$

 $R_{DS(ON)}$ < -25m Ω @ V_{GS} =10V

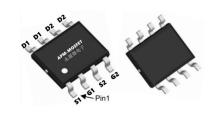


Application

Battery protection

Load switch

Uninterruptible power supply



Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP10G03S	SOP-8	AP6G03S XXX YYYY	3000

Absolute Maximum Ratings (Tc=25°Cunless otherwise noted)

		Rating		
Symbol	Symbol Parameter		P-Ch	Units
Vos	Drain-Source Voltage	30	-30	V
Vgs	Gate-Source Voltage	±20	±20	V
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	12	-9.8	Α
ID@TA=70°C	Continuous Drain Current, V _{GS} @ 10V ¹	7	-5.2	Α
IDM	Pulsed Drain Current ²	36	-26	А
EAS	Single Pulse Avalanche Energy ³	24	72	mJ
I AS	Avalanche Current	22	-38	Α
P _D @T _A =25°C	Total Power Dissipation ⁴	1.5	1.5	W
Тѕтс	Storage Temperature Range	-55 to 150	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	-55 to 150	°C
$R_{ heta}$ JA	Thermal Resistance Junction-Ambient ¹		85	°C/W
Rелс	Thermal Resistance Junction-Case ¹		25	°C/W



N-Channel Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V	
3BVpss/2TJ	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.023		V/°C	
		V _{GS} =10V , I _D =8A			12		
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =6A			18	mΩ	
VGS(th)	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1.2		2.5	V	
₹VGS(th)	V _{GS(th)} Temperature Coefficient			-5.08		mV/°C	
_	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	 	
Ipss		V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	uA	
Igss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =8A		24		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.8		Ω	
Qg	Total Gate Charge (4.5V)			9.63			
Qgs	Gate-Source Charge	V _{DS} =15V , V _{GS} =4.5V , I _D =8A		3.88		nC	
Q_{gd}	Gate-Drain Charge			3.44			
Td(on)	Turn-On Delay Time			4.2			
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V ,		8.2			
Td(off)	Turn-Off Delay Time	—R _G =1.5 I _D =8A		31		- ns	
T _f	Fall Time			4			
Ciss	Input Capacitance			940			
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		131		pF	
Crss	Reverse Transfer Capacitance			109			
ls	Continuous Source Current ^{1,5}				9	Α	
Іѕм	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			36	Α	
VsD	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1	V	
t _{rr}	Reverse Recovery Time			8		nS	
Qrr	Reverse Recovery Charge	—lF=8A , dl/dt=100A/μs , Tյ=25°C		2.9		nC	

Note:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leqq 300us , duty cycle \leqq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1 mH, L_{AS} =21A
- 4 .The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



P-Channel Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30			V
®BVpss/®TJ	BVDSS Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.022		V/°C
		V _{GS} =-10V , I _D =-6A			25	
Rds(on)	Static Drain-Source On-Resistance ²	V _{GS} =-4.5V , I _D =-4A			42	mΩ
V _{GS(th)}	Gate Threshold Voltage		-1.0		-2.5	V
₹VGS(th)	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, I_D =-250uA		4.6		mV/°C
la a a	Drain-Source Leakage Current	V_{DS} =-24V , V_{GS} =0V , T_{J} =25 $^{\circ}$ C			-1	
IDSS		V _{DS} =-24V , V _{GS} =0V , T _J =55°C			-5	uA
Igss	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-6A		17		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		13		
Qg	Total Gate Charge (-4.5V)			12.6		
Qgs	Gate-Source Charge	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-6A		4.8		nC
Q _{gd}	Gate-Drain Charge			4.8		
T _{d(on)}	Turn-On Delay Time			4.6		
Tr	Rise Time	V _{DD} =-15V , V _{GS} =-10V ,		14.8		
Td(off)	Turn-Off Delay Time	R _G =3.3 ,		41		ns
Tf	Fall Time			19.6		
Ciss	Input Capacitance			1345		
Coss	Output Capacitance	── V _{DS} =-15V , V _{GS} =0V , f=1MHz		194		pF
Crss	Reverse Transfer Capacitance			158		
Is	Continuous Source Current ^{1,5}				-6.5	A
Ism	Pulsed Source Current ^{2,5}	─V _G =V _D =0V , Force Current			-26	A
VsD	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1.2	V

Note

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZcopper.
- 2.The data tested by pulsed , pulse width \leqq 300us , duty cycle \leqq 2%
- 3. The EAS data sh. The power dissipation is limited by ows Max. rating
- 4. The test condition is V150 $^{\circ}$ C junction temperature DD = -25 V,VGS = -10V,L=0.1mH,IAS = -30A
- 5 .The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.





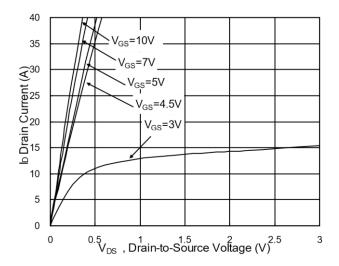


Fig.1 Typical Output Characteristics

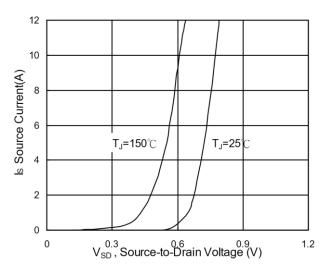


Fig.3 Forward Characteristics of Reverse

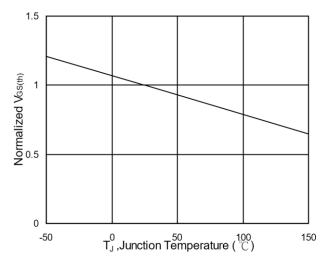


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_{J}

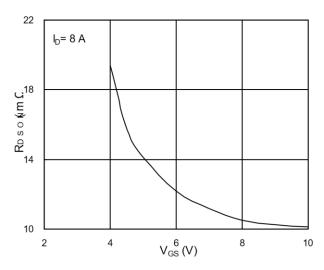


Fig.2 On-Resistance vs. G-S Voltage

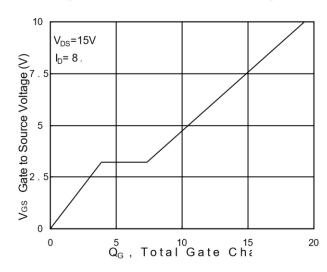


Fig.4 Gate-Charge Characteristics

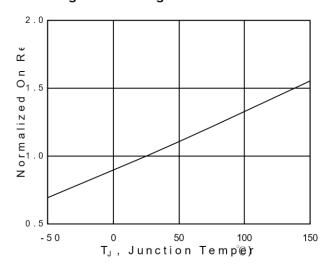
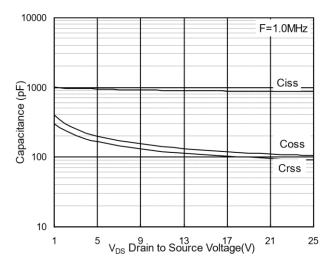


Fig.6 Normalized R_{DSON} vs. T_J







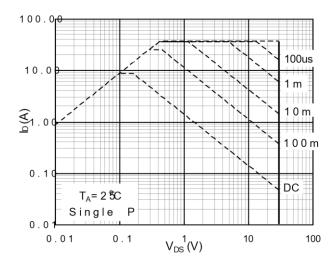


Fig.7 Capacitance

Fig.8 Safe Operating Area

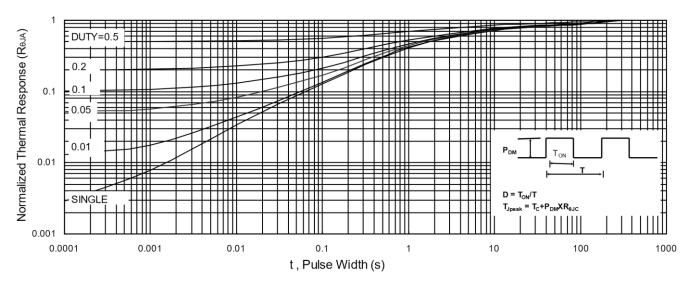
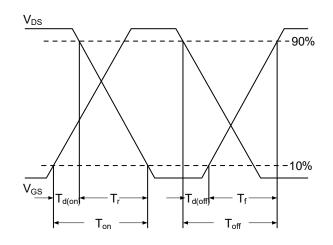


Fig.9 Normalized Maximum Transient Thermal Impedance



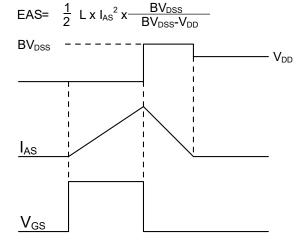


Fig.10 Switching Time Waveform

Fig.11 Unclamped Inductive Switching Waveform





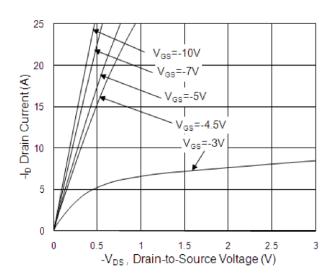


Fig.1 Typical Output Characteristics

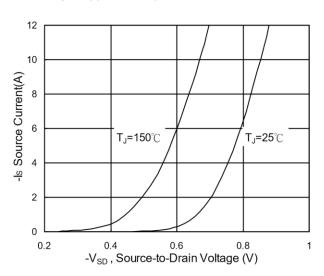


Fig.3 Forward Characteristics of Reverse

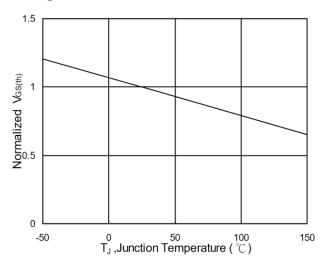


Fig.5 Normalized V_{GS(th)} v.s T_J

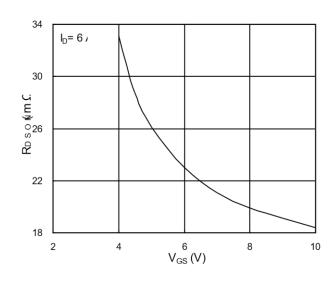


Fig.2 On-Resistance v.s Gate-Source

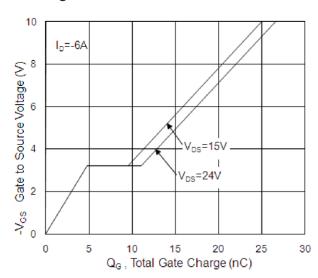


Fig.4 Gate-Charge Characteristics

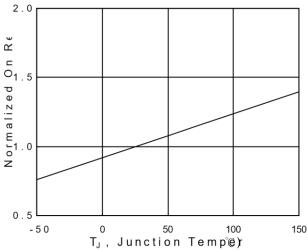
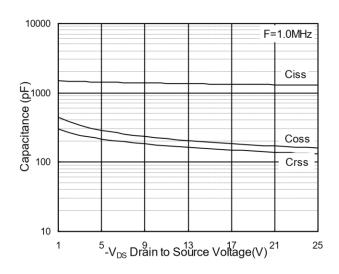


Fig.6 Normalized R_{DSON} v.s T_{J}







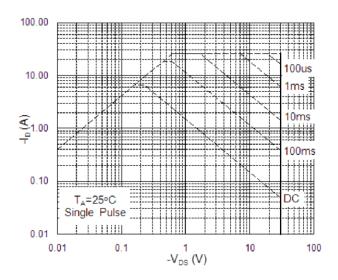


Fig.7 Capacitance

Fig.8 Safe Operating Area

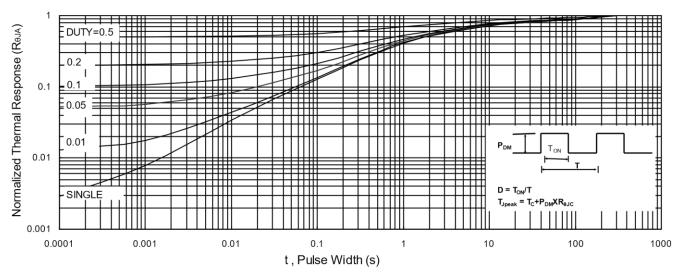
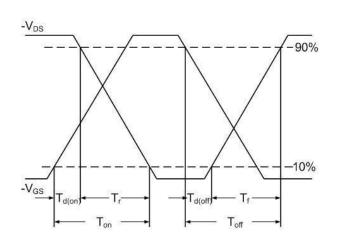


Fig.9 Normalized Maximum Transient Thermal Impedance





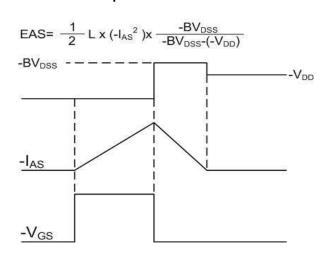
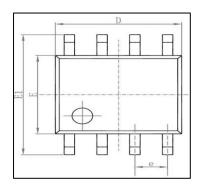
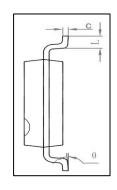


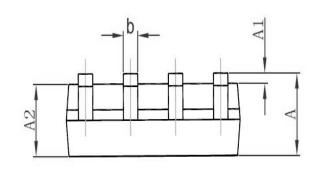
Fig.11 Unclamped Inductive Switching Waveform



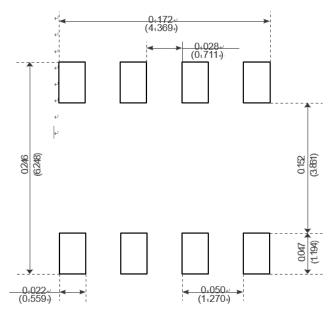
Package Mechanical Data-SOP-8/ESOP-8







Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
Α	1. 350	1. 750	0. 053	0.069
A1	0. 100	0. 250	0. 004	0. 010
A2	1. 350	1. 550	0. 053	0. 061
b	0. 330	0. 510	0. 013	0. 020
С	0. 170	0. 250	0.006	0. 010
D	4. 700	5. 100	0. 185	0. 200
E	3. 800	4. 000	0. 150	0. 157
E1	5. 800	6. 200	0. 228	0. 244
е	1. 270 (BSC)		0. 050 (BSC)	
L	0. 400	1. 270	0. 016	0. 050
θ	0°	8°	0°	8°



Recommended Minimum Pads-





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